

Description

The XPX18N10XE uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

ROHS

VDS =100V,ID =18A

RDS(ON)= $65m\Omega$ (typ) @ VGS=10V

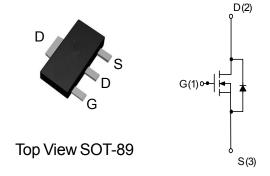
RDS(ON)= $85m\Omega$ (typ) @ VGS=4.5V

General Features

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

Application

- PWM
- Load Switching



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
XPX18N10XE	XPX18N10XE	SOT89-3	-	-	-

Absolute Maximum Ratings (T_C=25 ℃ unless otherwise noted)

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Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	100	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current-Continuous	I _D	18	Α
Drain Current-Continuous(T _C =100°C)	I _D (100°ℂ)	10	Α
Pulsed Drain Current	I _{DM}	68	Α
Maximum Power Dissipation	P _D	45	W
Single pulse avalanche energy (Note 5)	Eas	200	mJ
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 175	$^{\circ}\!\mathbb{C}$
Thermal Resistance, Junction-to-Case ^(Note 2)	R _{θJC}	3.0	°C/W



Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•			
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100	110	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.2	1.8	2.5	V
Drain Course On State Desistance	D.	V _{GS} =10V, I _D =18A	-	- 65 75		0
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =10A	-	72	86	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =10A	-	10	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C _{lss}		-	880	-	PF
Output Capacitance	Coss	V_{DS} =50 V , V_{GS} =0 V ,	-	46	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz	-	33	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	15	-	nS
Turn-on Rise Time	t _r	V_{DD} =50 V , R_L =6. 4Ω	-	5	-	nS
Turn-Off Delay Time	t _{d(off)}	$V_{GS}\text{=}10V,R_{G}\text{=}3\Omega$	-	25	-	nS
Turn-Off Fall Time	t _f		-	7	-	nS
Total Gate Charge	Qg	V -F0VI -10A	-	22.3		nC
Gate-Source Charge	Q _{gs}	$V_{DS}=50V,I_{D}=18A,$	-	2.87	-	nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V	-	6.14	-	nC
Drain-Source Diode Characteristics	<u>, </u>		•			
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =18A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	18	Α

Notes:

- $\textbf{1.} \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature}.$
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition : Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω



Typical Electrical and Thermal Characteristics (Curves)

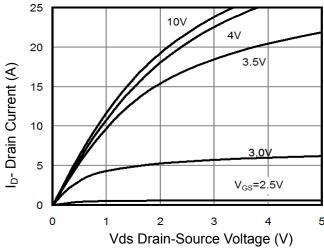


Figure 1 Output Characteristics

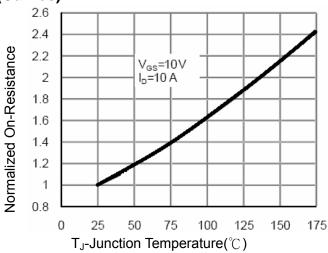


Figure 4 Rdson-JunctionTemperature

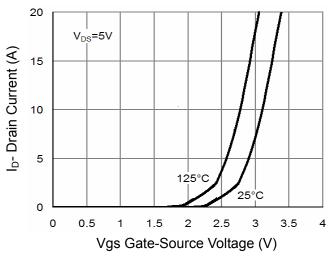


Figure 2 Transfer Characteristics

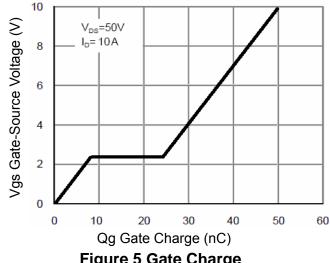


Figure 5 Gate Charge

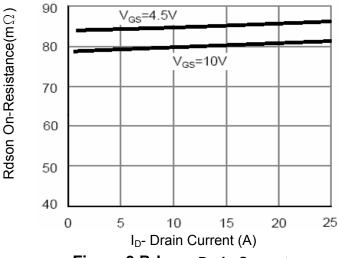


Figure 3 Rdson- Drain Current

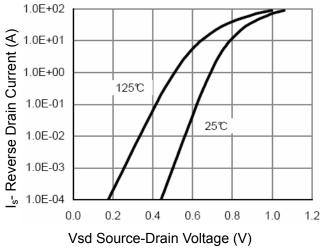


Figure 6 Source- Drain Diode Forward



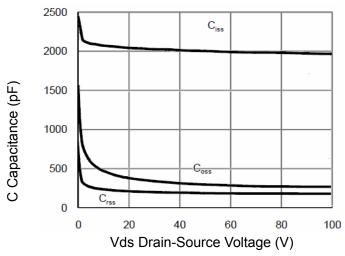


Figure 7 Capacitance vs Vds

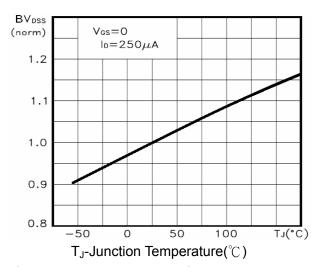


Figure 9 BV_{DSS} vs Junction Temperature

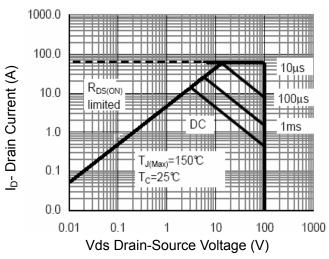


Figure 8 Safe Operation Area

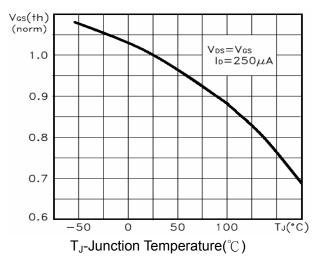


Figure 10 V_{GS(th)} vs Junction Temperature

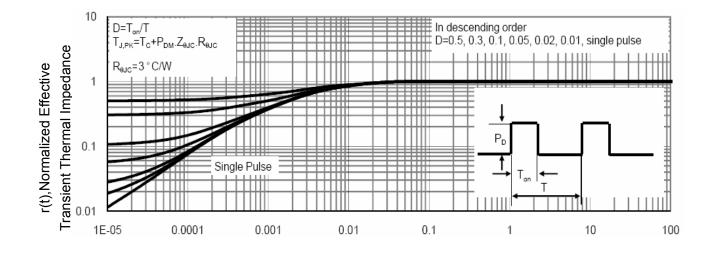
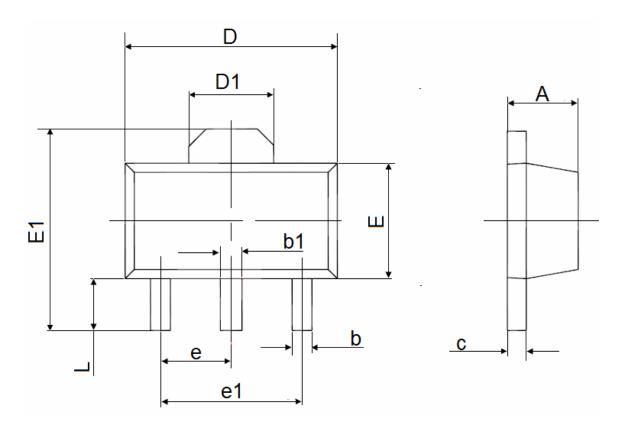


Figure 11 Normalized Maximum Transient Thermal Impedance

Square Wave Pluse Duration(sec)



SOT-89-3L Package Information



Symbol	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.400	1.600	0.055	0.063	
b	0.320	0.520	0.013	0.020	
b1	0.400	0.580	0.016	0.023	
С	0.350	0.440	0.014	0.017	
D	4.400	4.600	0.173	0.181	
D1	1.550 REF.		0.061 REF.		
E	2.300	2.600	0.091	0.102	
E1	3.940	4.250	0.155	0.167	
е	1.500 TYP.		0.060 TYP.		
e1	3.000 TYP.		0.118 TYP.		
L	0.900	1.200	0.035	0.047	



Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time	
Pb device	245℃±5℃	5sec±1sec	
Pb-Free device	260℃+0/-5℃	5sec±1sec	



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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